Application/Control No. Applicant(s)/Patent Under Reexamination 10/728,517 KIM ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Toniae M. Thomas 2822 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2002/0180055 A1 12-2002 Takahashi et al. Α 257/774 US-2003/0047539 A1 В 03-2003 Ma et al. 216/89 С US-2005/0227496 A1 10-2005 Park et al. 438/745 US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Country Code-Number-Kind Code MM-YYYY Classification N 0 P Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

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